1. Product profile

1.1 General description

The device is designed to protect high-speed interfaces such as SuperSpeed and Hi-Speed USB combination, Secure Digital (SD) card 3.0 and Thunderbolt interfaces against ElectroStatic Discharge (ESD).

The device includes six high-level ESD protection diode structures. They protect sensitive transmitters and receivers for ultra high-speed signal lines. The device is encapsulated in a leadless ultra small DFN2111-7 (SOT1358-1) Surface-Mounted Device (SMD) plastic package.

All signal lines are protected by a special diode configuration offering snapback ultra low line capacitance of only 0.15 pF. These diodes utilize a snapback structure in order to provide protection to downstream components from ESD voltages up to ± 15 kV contact exceeding IEC 61000-4-2, level 4.

1.2 Features and benefits

- System-level ESD protection for USB 2.0 and USB 3.1 combination, SD card 3.0 and Thunderbolt interfaces
- Supports SuperSpeed USB 3.1 at 10 Gbps
- Line capacitance of only 0.15 pF for each channel
- All signal lines with integrated rail-to-rail clamping diodes for downstream ESD protection of ±15 kV exceeding IEC 61000-4-2, level 4
- Matched 0.5 mm trace spacing
- Design-friendly pass-through signal routing

1.3 Applications

The device is designed for high-speed receiver and transmitter port protection:

- Portable and wearable devices
- Smartphones, tablet computers
- TVs and monitors
- DVD recorders and players
- Notebooks, main board graphic cards and ports
- Set-top boxes and game consoles



ESD protection for ultra high-speed interfaces

2. Pinning information

Table 1. Pinning

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	CH1	channel 1 ESD protection		4 0 4 5 0 7
2	GND	ground [1]	1 1	1 3 4 5 6 7
3	CH2	channel 2 ESD protection	7	
4	CH3	channel 3 ESD protection	2	<u>¥</u>
5	CH4	channel 4 ESD protection	6	-
6	CH5	channel 5 ESD protection	3	
7	СН6	channel 6 ESD protection	Transparent top view	aaa-016888

^[1] Any pin can be chosen for ground connection; one pin must be connected to ground.

3. Ordering information

Table 2. Ordering information

Type number	Package				
	Name	Description	Version		
PUSB3AB6		plastic extremely thin small outline package; no leads; 7 terminals; body $1.1 \times 2.1 \times 0.5$ mm	SOT1358-1		

4. Marking

Table 3. Marking codes

Type number	Marking code
PUSB3AB6	AB

ESD protection for ultra high-speed interfaces

5. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
VI	input voltage		-3.3	+3.3	V
V _{ESD}	electrostatic discharge voltage	IEC 61000-4-2, level 4 [1]			
		contact discharge	-15	+15	kV
		air discharge	-15	+15	kV
I _{PPM}	rated peak pulse current	t _p = 8/20 μs	-7	+7	Α
T _{amb}	ambient temperature		-40	+85	°C
T _{stg}	storage temperature		-55	+125	°C

^[1] All pins to ground.

6. Characteristics

Table 5. Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

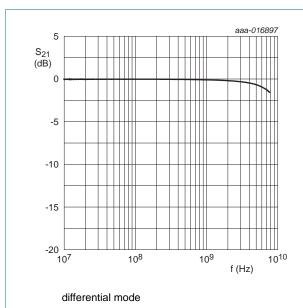
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V_{BR}	breakdown voltage	I _I = 1 mA		6	-	-	V
I_{LR}	reverse leakage current	per channel; V _I = 5 V		-	1	100	nA
C _{line}	line capacitance	f = 1 MHz; V _I = 1.5 V	[1]	-	0.15	0.20	pF
r _{dyn}	dynamic resistance	TLP	[3]				
		positive transient		-	0.4	-	Ω
		negative transient		-	0.4	-	Ω
V_{sbck}	snapback voltage	I _I = 1 A TLP; 100/10 ns		-	3	-	V
V_{CL}	clamping voltage	I _{PP} = 5 A; positive transient	[2]	-	6	-	V
		I _{PP} = −5 A; negative transient	[2]	-	-6	-	V

^[1] This parameter is guaranteed by design.

^[2] According to IEC 61000-4-5 (pulse time t_{p} = 8/20 $\mu s).$

^{[3] 100} ns Transmission Line Pulse (TLP); 50 Ω ; pulser at 80 ns.

ESD protection for ultra high-speed interfaces

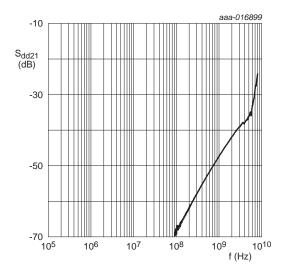


1.2 aaa-016898
0.8
0.4
0 1 2 3 4 5 V_I (V) 5

$$a = \frac{C_{line}}{C_{line(V_I = 0 \text{ V})}}$$

Fig 1. Insertion loss; typical values

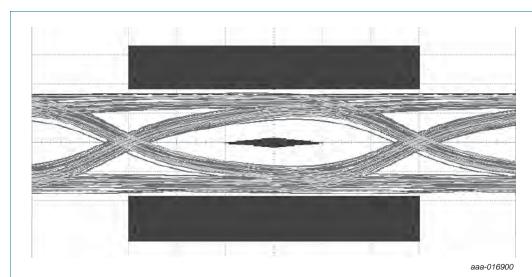
Fig 2. Relative capacitance as a function of input voltage; typical values



Sdd21 normalized to 100 Ω

Fig 3. Crosstalk; typical values

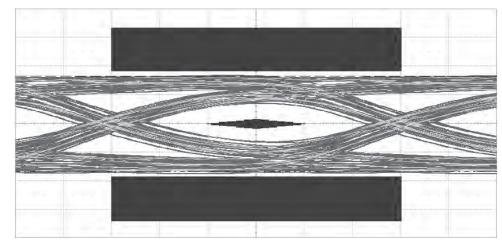
ESD protection for ultra high-speed interfaces



Data rate: 10 Gbit/s

Vertical scale: 325 mV/div Horizontal scale: 16.7 ps/div

Fig 4. USB 3.1 eye diagram, Printed-Circuit Board (PCB) with PUSB3AB6

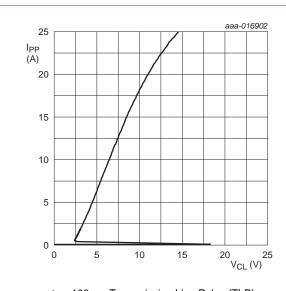


aaa-016901

Data rate: 10 Gbit/s Vertical scale: 325 mV/div Horizontal scale: 16.7 ps/div

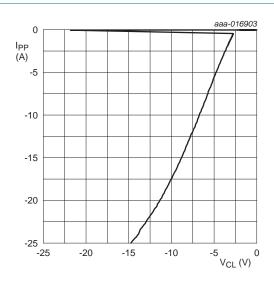
Fig 5. USB 3.1 eye diagram, PCB without PUSB3AB6 (reference)

ESD protection for ultra high-speed interfaces



 t_p = 100 ns; Transmission Line Pulse (TLP)

Fig 6. Dynamic resistance with positive clamping; typical values



 t_p = 100 ns; Transmission Line Pulse (TLP)

Fig 7. Dynamic resistance with negative clamping; typical values

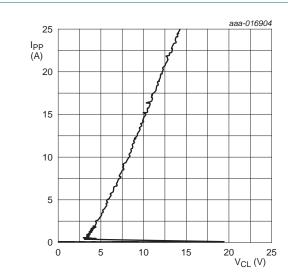
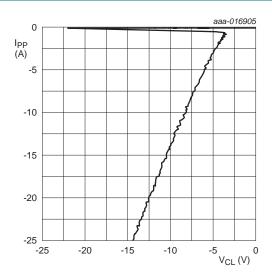


Fig 8. Dynamic resistance with positive clamping; typical values

t_p = 5 ns; Very-Fast Transmission-Line Pulse (VF-TLP)



t_p = 5 ns; Very-Fast Transmission-Line Pulse (VF-TLP)

Fig 9. Dynamic resistance with negative clamping; typical values

The device uses an advanced clamping structure showing a negative dynamic resistance. This snapback behavior strongly reduces the clamping voltage to the system behind the ESD protection during an ESD event. Do not connect unlimited DC current sources to the data lines to avoid keeping the ESD protection device in snapback state after exceeding breakdown voltage (due to an ESD pulse for instance).

ESD protection for ultra high-speed interfaces

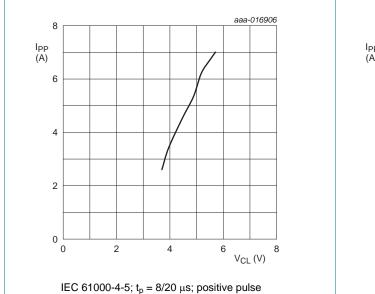
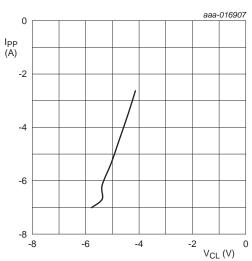


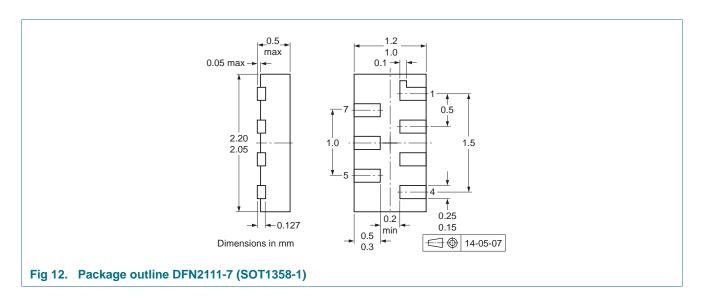
Fig 10. Dynamic resistance with positive clamping; typical values



IEC 61000-4-5; t_p = 8/20 μ s; negative pulse

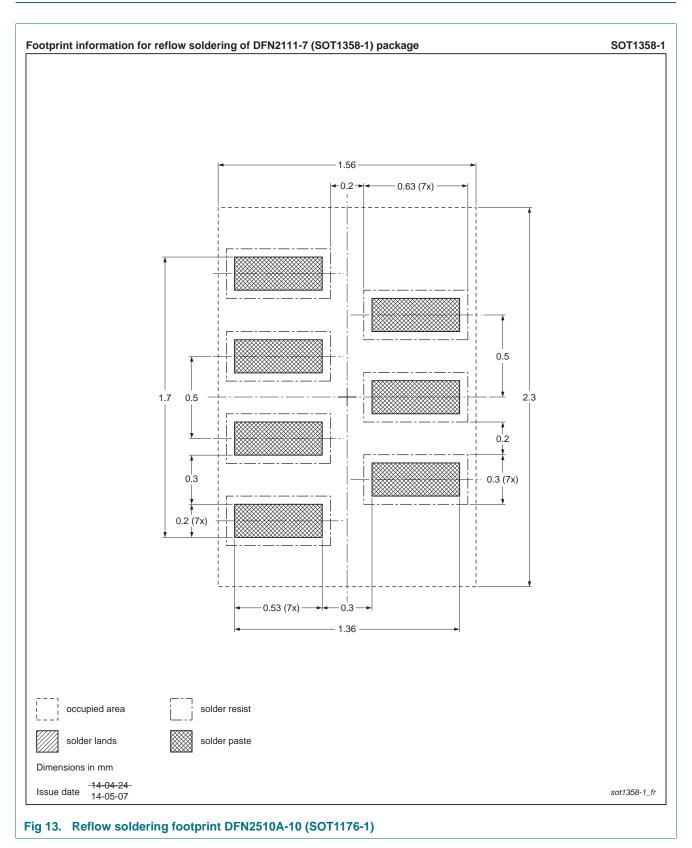
Fig 11. Dynamic resistance with negative clamping; typical values

7. Package outline



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8. Soldering



ESD protection for ultra high-speed interfaces

9. Revision history

Table 6. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PUSB3AB6 v.1	20150303	Product data sheet	-	-

ESD protection for ultra high-speed interfaces

10. Legal information

10.1 Data sheet status

Document status[1][2] Product status[3]		Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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